

Notice of References Cited	Application/Control No. 09/618,537	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner CHAN S. PARK	Art Unit 2625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,388,711	05-2002	Han et al.	348/441
*	B	US-6,377,360	04-2002	Hattori, Yutaka	358/1.5
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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